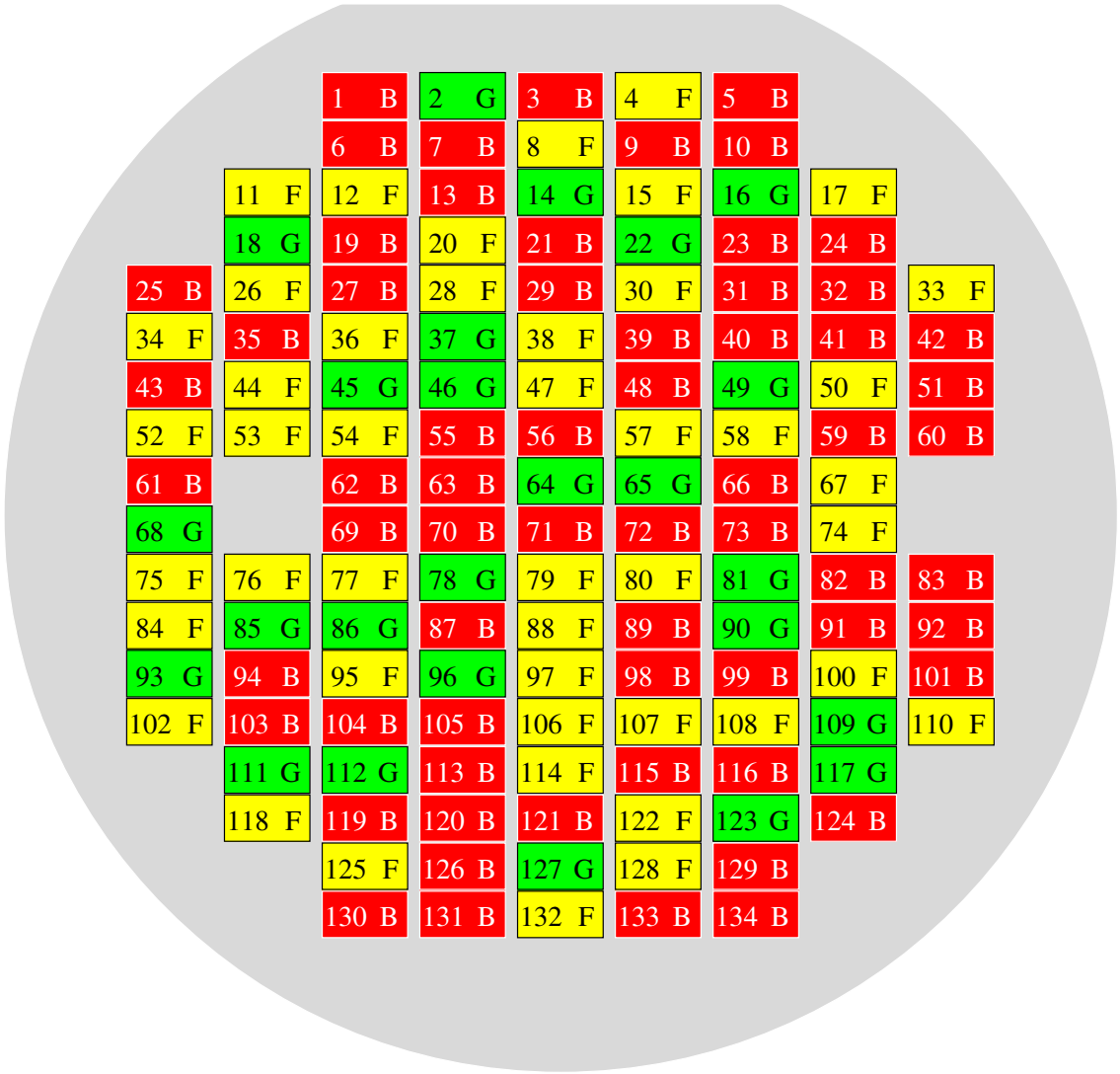
Die quality map for wafer 187 s/n: 21316-13-12

Date: 08/13/99



B Bad die

F Fair die

G Good die

N No info

* Manually tagged